

## Product Summary

$BV_{DSS}$ (@ $T_J$ Max)	$R_{DS(ON)}$	$I_D$ $T_c = +25^\circ C$
650V	2.5Ω@ $V_{GS} = 10V$	4.5A

## Description

This new generation MOSFET features low on-resistance and fast switching, making it ideal for high efficiency power management applications.

## Applications

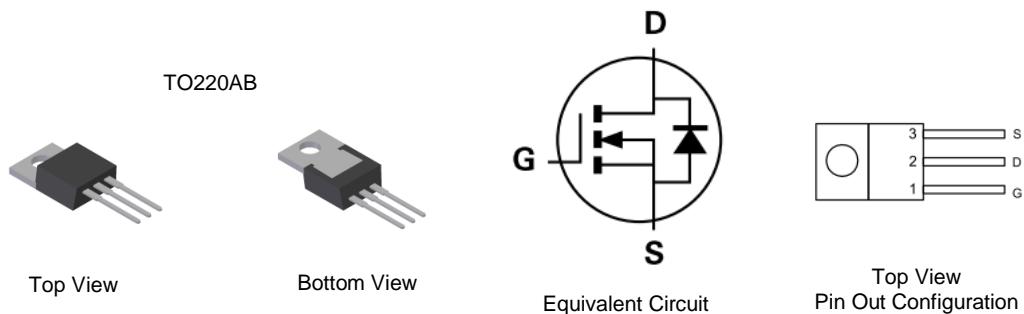
- Motor Control
- Backlighting
- DC-DC Converters
- Power Management Functions

## Features

- Low Input Capacitance
- High  $BV_{DSS}$  Rating for Power Application
- Low Input/Output Leakage
- **Lead-Free Finish; RoHS Compliant (Notes 1 & 2)**
- Halogen and Antimony Free. "Green" Device (Note 3)

## Mechanical Data

- Case: TO220AB
- Case Material: Molded Plastic, "Green" Molding Compound, UL Flammability Classification Rating 94V-0
- Terminals: Matte Tin Finish Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 ⑥③
- Terminal Connections: See Diagram Below
- Weight: TO220AB – 1.85 grams (Approximate)



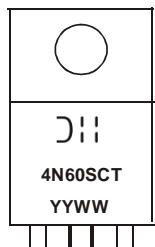
## Ordering Information (Note 4)

Part Number	Case	Packaging
DMG4N60SCT	TO220AB	50 pieces/tube

Notes:

1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
2. See [http://www.diodes.com/quality/lead\\_free.html](http://www.diodes.com/quality/lead_free.html) for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

## Marking Information



DII = Manufacturer's Marking  
 4N60SCT = Product Type Marking Code  
 YYWW = Date Code Marking  
 YY or YY = Last Two Digits of Year (ex: 16 = 2016)  
 WW or WW = Week Code (01 to 53)

**Maximum Ratings** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			$V_{DSS}$	600	V
Gate-Source Voltage			$V_{GSS}$	$\pm 30$	V
Continuous Drain Current (Note 5) $V_{GS} = 10\text{V}$	Steady State	$T_C = +25^\circ\text{C}$ $T_C = +100^\circ\text{C}$	$I_D$	4.5 3	A
Maximum Body Diode Forward Current (Note 5)			$I_S$	6	A
Pulsed Drain Current (10 $\mu\text{s}$ pulse, duty cycle = 1%)			$I_{DM}$	6	A
Avalanche Current, $L = 60\text{mH}$ (Note 6)			$I_{AS}$	1.7	A
Avalanche Energy, $L = 60\text{mH}$ (Note 6)			$E_{AS}$	90	mJ

**Thermal Characteristics**

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_C = +25^\circ\text{C}$	$P_D$	113	W
	$T_C = +100^\circ\text{C}$		45	
Thermal Resistance, Junction to Ambient (Note 5)		$R_{\theta JA}$	58	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction to Case (Note 5)		$R_{\theta JC}$	1.1	
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 7)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	600	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$I_{DSS}$	—	—	1	$\mu\text{A}$	$V_{DS} = 600\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	$I_{GSS}$	—	—	100	nA	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$
<b>ON CHARACTERISTICS (Note 7)</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	2.5	—	4.5	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	2.0	2.5	$\Omega$	$V_{GS} = 10\text{V}, I_D = 2\text{A}$
Diode Forward Voltage	$V_{SD}$	—	—	1.4	V	$V_{GS} = 0\text{V}, I_S = 1\text{A}$
<b>DYNAMIC CHARACTERISTICS (Note 6)</b>						
Input Capacitance	$C_{iss}$	—	532	—	$\text{pF}$	$V_{DS} = 25\text{V}, f = 1.0\text{MHz}, V_{GS} = 0$
Output Capacitance	$C_{oss}$	—	47	—		
Reverse Transfer Capacitance	$C_{rss}$	—	4	—		
Gate Resistance	$R_G$	—	3.3	—	$\Omega$	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Total Gate Charge ( $V_{GS} = 10\text{V}$ )	$Q_g$	—	14.3	—	$\text{nC}$	$V_{DD} = 480\text{V}, I_D = 4\text{A}, V_{GS} = 10\text{V}$
Gate-Source Charge	$Q_{gs}$	—	3.3	—		
Gate-Drain Charge	$Q_{gd}$	—	6.9	—		
Turn-On Delay Time	$t_{D(ON)}$	—	14	—	$\text{ns}$	$V_{DD} = 300\text{V}, R_G = 25\Omega, I_D = 4\text{A}, V_{GS} = 10\text{V}$
Turn-On Rise Time	$t_R$	—	34	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	32	—		
Turn-Off Fall Time	$t_F$	—	25	—		
Body Diode Reverse Recovery Time	$t_{RR}$	—	229	—	$\text{ns}$	$dl/dt = 100\text{A}/\mu\text{s}, V_{DS} = 100\text{V}, I_F = 4\text{A}$
Body Diode Reverse Recovery Charge	$Q_{RR}$	—	1564	—	$\text{nC}$	

Notes:

5. Device mounted on an infinite heatsink.
6. Guaranteed by design. Not subject to production testing.
7. Short duration pulse test used to minimize self-heating effect.

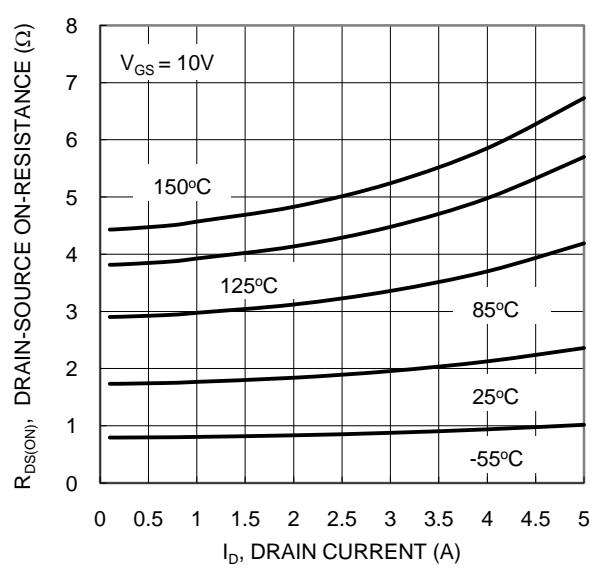
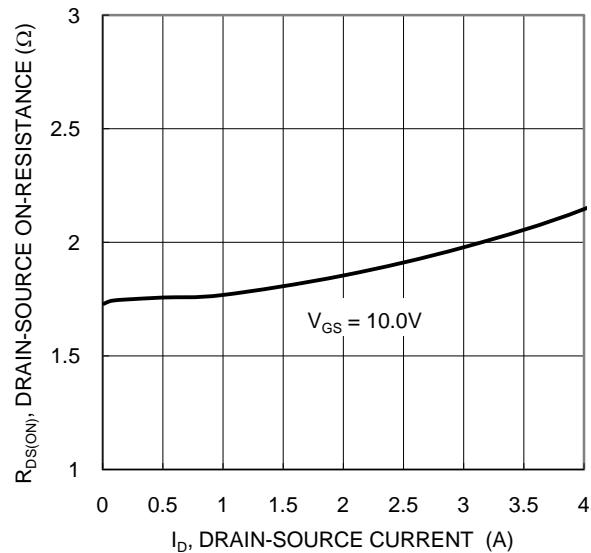
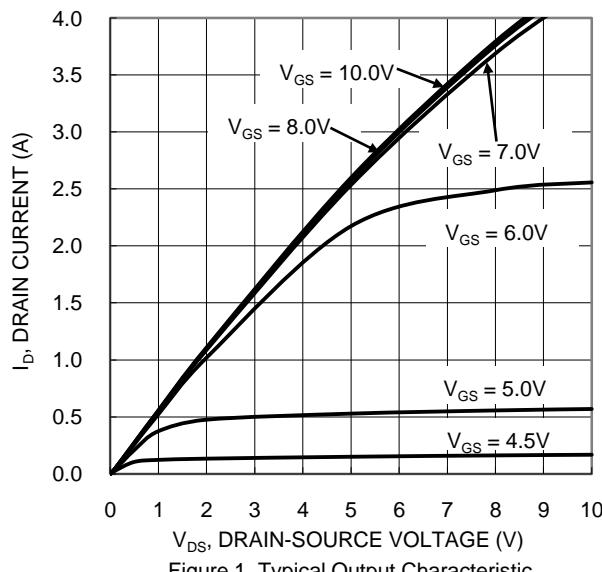
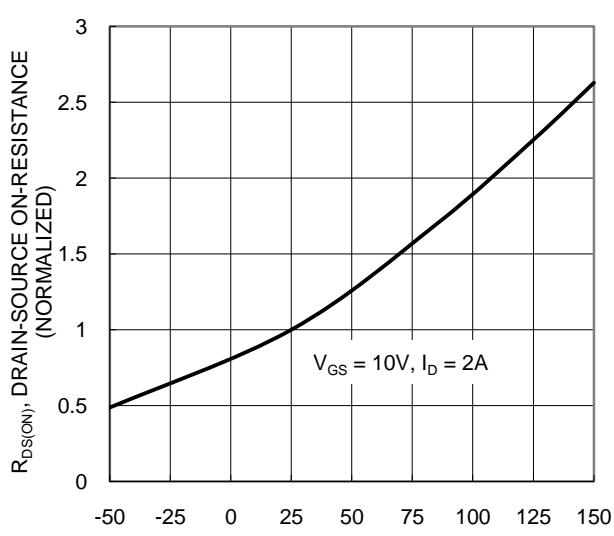
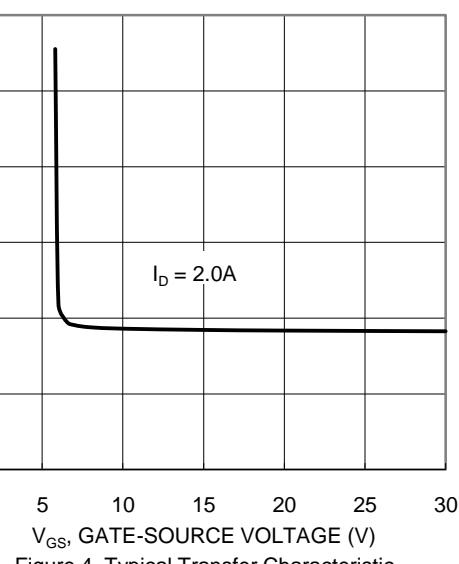
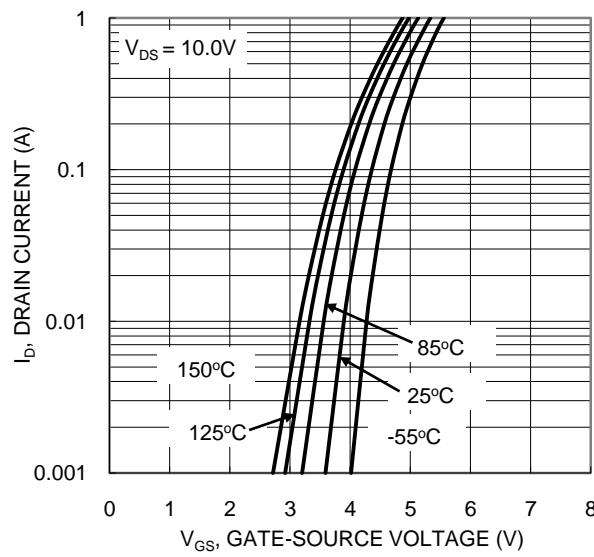


Figure 5. Typical On-Resistance vs Drain Current and Temperature



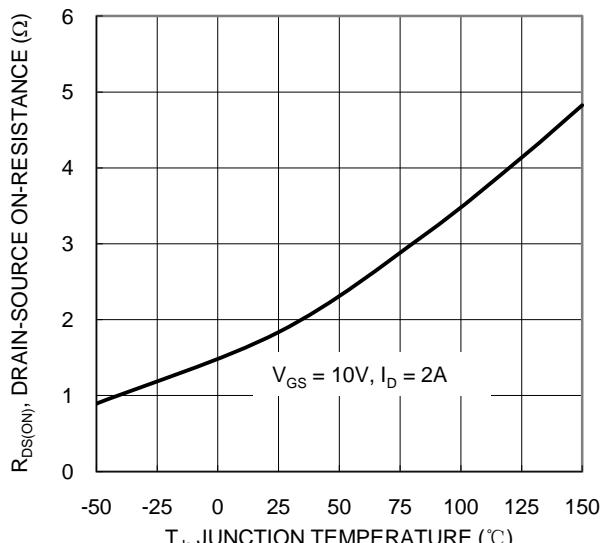


Figure 7. On-Resistance Variation with Temperature

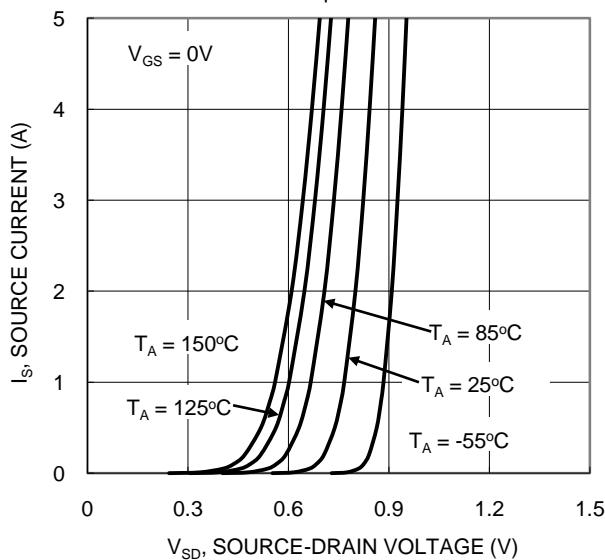


Figure 9. Diode Forward Voltage vs Current

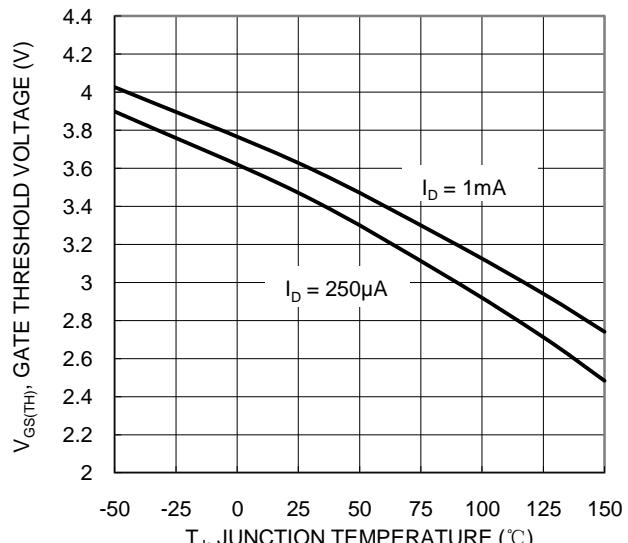


Figure 8. Gate Threshold Variation vs Junction Temperature

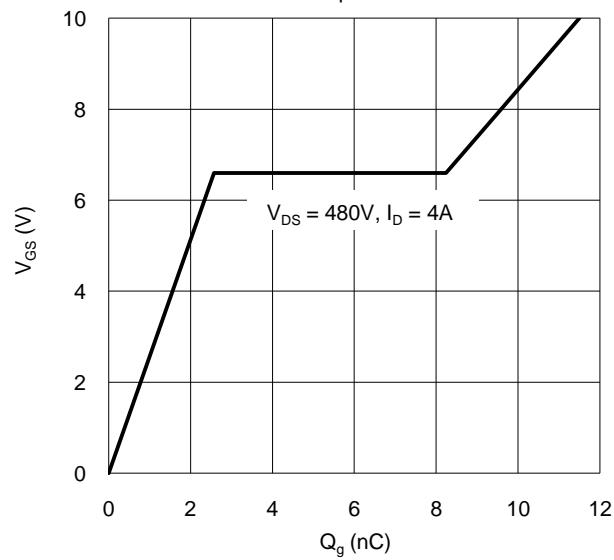


Figure 10. Gate Charge

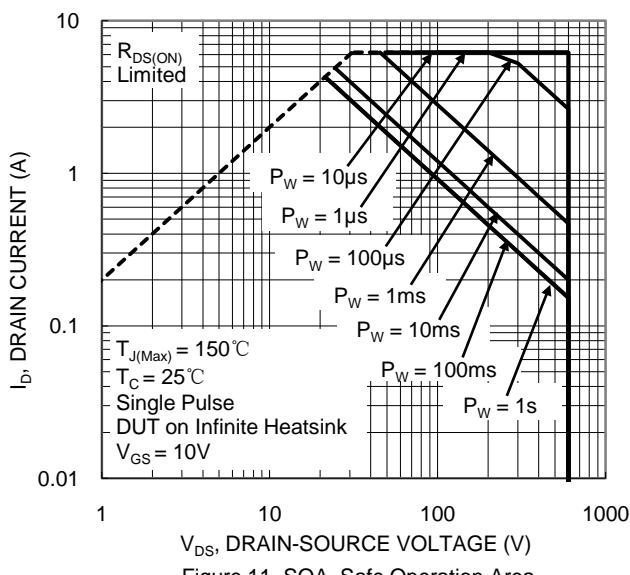


Figure 11. SOA, Safe Operation Area

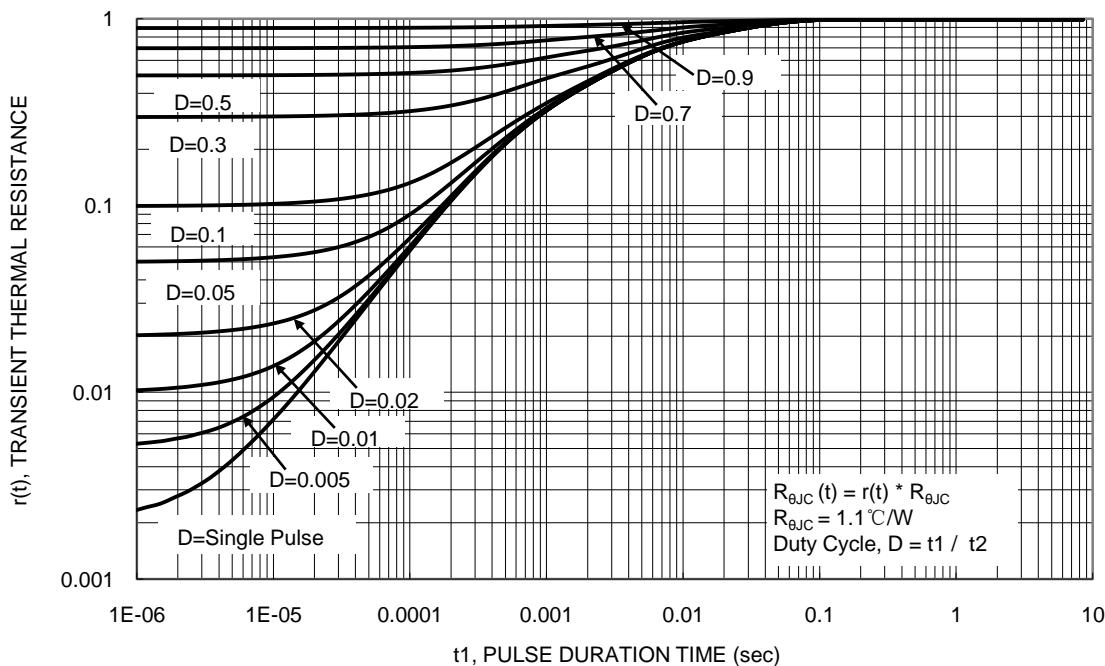
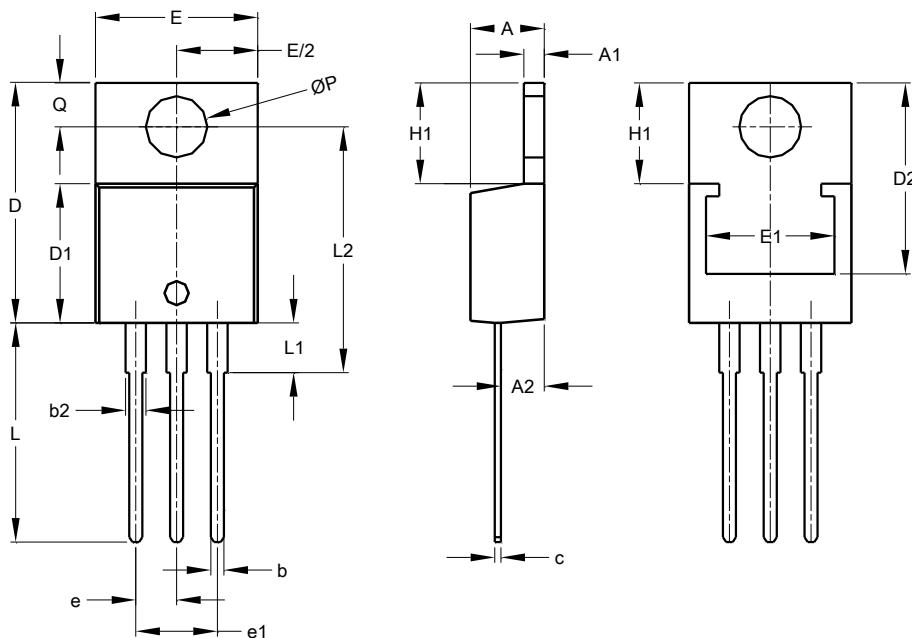


Figure 12. Transient Thermal Resistance

## Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

TO220AB



TO220AB			
Dim	Min	Max	Typ
<b>A</b>	3.56	4.82	-
<b>A1</b>	0.51	1.39	-
<b>A2</b>	2.04	2.92	-
<b>b</b>	0.39	1.01	0.81
<b>b2</b>	1.15	1.77	1.24
<b>c</b>	0.356	0.61	-
<b>D</b>	14.22	16.51	-
<b>D1</b>	8.39	9.01	-
<b>D2</b>	11.45	12.87	-
<b>e</b>	-	-	2.54
<b>e1</b>	-	-	5.08
<b>E</b>	9.66	10.66	-
<b>E1</b>	6.86	8.89	-
<b>H1</b>	5.85	6.85	-
<b>L</b>	12.70	14.73	-
<b>L1</b>	-	6.35	-
<b>L2</b>	15.80	16.20	16.00
<b>P</b>	3.54	4.08	-
<b>Q</b>	2.54	3.42	-
All Dimensions in mm			

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